# imall

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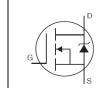
**AUTOMOTIVE GRADE** 



### AUIRFR3710Z

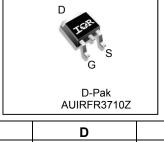
#### **Features**

- Advanced Process Technology •
- Ultra Low On-Resistance •
- 175°C Operating Temperature
- Fast Switching •
- Repetitive Avalanche Allowed up to Timax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*



HEXFET <sup>®</sup> Power MOSFET
----------------------------------

V <sub>DSS</sub>	100V
R <sub>DS(on)</sub> max.	18mΩ
D (Silicon Limited)	56A
D (Package Limited)	42A



#### Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating . These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

		AUIRFR3710Z	
G		D	S
Gate		Drain	Source

Bass nort number	Deekege Ture	Standard Pack Form Quantity Orderable Part N		Standard Pack		Ordershie Bart Number
Base part number	Package Type			Orderable Part Number		
AUIRFR3710Z	D Dak	Tube	75	AUIRFR3710Z		
AUIRER3/ 10Z	D-Pak	Tape and Reel Left	3000	AUIRFR3710ZTRL		

#### Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	56		
I <sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Silicon Limited)	39	A	
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V (Package Limited)	42	A	
I <sub>DM</sub>	Pulsed Drain Current ①	220		
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	140	W	
	Linear Derating Factor	0.95	W/°C	
V <sub>GS</sub>	Gate-to-Source Voltage	± 20	V	
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) 2	150		
E <sub>AS</sub> (Tested)	Single Pulse Avalanche Energy Tested Value 6	200	mJ	
I <sub>AR</sub>	Avalanche Current ①	See Fig.15,16, 12a, 12b	A	
E <sub>AR</sub>	Repetitive Avalanche Energy S		mJ	
TJ	Operating Junction and	-55 to + 175		
T <sub>STG</sub>				
	Soldering Temperature, for 10 seconds (1.6mm from case)	300		

#### Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
R <sub>θJC</sub>	Junction-to-Case ®		1.05	
$R_{ ext{ heta}JA}$	Junction-to-Ambient (PCB Mount) 🗇		50	°C/W
$R_{ heta JA}$	Junction-to-Ambient		110	

HEXFET® is a registered trademark of Infineon.

\*Qualification standards can be found at www.infineon.com



## AUIRFR3710Z

#### Static @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	100			V	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250μA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.088		V/°C	Reference to $25^{\circ}$ C, I <sub>D</sub> = 1mA
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		15	18	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 33A ③
V <sub>GS(th)</sub>	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	39			S	V <sub>DS</sub> = 25V, I <sub>D</sub> = 33A ③
1	Drain to Source Lookage Current			20		V <sub>DS</sub> = 100V, V <sub>GS</sub> = 0V
I <sub>DSS</sub> Drai	Drain-to-Source Leakage Current			250	μA	V <sub>DS</sub> = 100V,V <sub>GS</sub> = 0V,T <sub>J</sub> =125°C
	Gate-to-Source Forward Leakage			200	-	V <sub>GS</sub> = 20V
	Gate-to-Source Reverse Leakage			-200	nA	V <sub>GS</sub> = -20V

#### Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

Q <sub>g</sub>	Total Gate Charge		69	100		I <sub>D</sub> = 33A
$Q_{gs}$	Gate-to-Source Charge		15		nC	V <sub>DS</sub> = 80V
Q <sub>gd</sub>	Gate-to-Drain Charge		25			V <sub>GS</sub> = 10V③
t <sub>d(on)</sub>	Turn-On Delay Time		14			$V_{DD} = 50V$
t <sub>r</sub>	Rise Time		43			I <sub>D</sub> = 33A
t <sub>d(off)</sub>	Turn-Off Delay Time		53		ns	$R_{G} = 6.8\Omega$
t <sub>f</sub>	Fall Time		42			V <sub>GS</sub> = 10V③
L <sub>D</sub>	Internal Drain Inductance		4.5		<u>л</u> Ц	Between lead, 6mm (0.25in.)
L <sub>S</sub>	Internal Source Inductance		7.5		1111	from package and center of die contact
C <sub>iss</sub>	Input Capacitance		2930			V <sub>GS</sub> = 0V
Coss	Output Capacitance		290			V <sub>DS</sub> = 25V
C <sub>rss</sub>	Reverse Transfer Capacitance		180		pF	<i>f</i> = 1.0MHz
C <sub>oss</sub>	Output Capacitance		1200		рі	$V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$
C <sub>oss</sub>	Output Capacitance		180			$V_{GS} = 0V, V_{DS} = 80V f = 1.0MHz$
C <sub>oss eff.</sub>	Effective Output Capacitance		430			$V_{GS}$ = 0V, $V_{DS}$ = 0V to 80V ④
	racteristics					
	Parameter	Min.	Тур.	Max.	Units	Conditions
ls	Continuous Source Current (Body Diode)			56		MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current			220		integral reverse

① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)

(Body Diode) ①

Diode Forward Voltage

Forward Turn-On Time

**Reverse Recovery Time** 

Reverse Recovery Charge

 $\odot$  Limited by T<sub>Jmax</sub>, starting T<sub>J</sub> = 25°C, L = 0.28mH, R<sub>G</sub> = 25 $\Omega$ , I<sub>AS</sub> = 33A, V<sub>GS</sub> =10V. Part not recommended for use above this value. ③ Pulse width  $\leq$  1.0ms; duty cycle  $\leq$  2%.

④ Coss eff. is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 80% VDSS

© Limited by T<sub>Jmax</sub>, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.

(i) This value determined from sample failure population, starting  $T_J = 25^{\circ}$ C, L = 0.28mH, R<sub>G</sub> = 25 $\Omega$ , I<sub>AS</sub> = 33A, V<sub>GS</sub> = 10V.

When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to 0 application note #AN-994

8  $R_{\theta}$  is measured at T<sub>J</sub> approximately 90°C. p-n junction diode.

di/dt = 100A/µs ③

1.3

53

62

35

41

V

ns

nC

Intrinsic turn-on time is negligible (turn-on is dominated by  $L_{s}+L_{D}$ )

T<sub>J</sub> = 25°C,I<sub>S</sub> = 33A, V<sub>GS</sub> = 0V ③

T<sub>J</sub> = 25°C ,I<sub>F</sub> = 33A, V<sub>DD</sub> = 50V

I<sub>SM</sub>

 $V_{SD}$ 

trr

Qrr

t<sub>on</sub>

Notes:



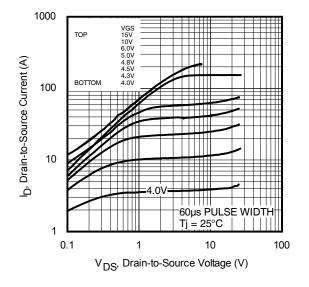




Fig. 2 Typical Output Characteristics

 $\mathsf{V}_{DS}$ , Drain-to-Source Voltage (V)

4.0

⁻60µs PULSE WIDTH Tj = 175°C

100

10

1000

l<sub>D</sub>, Drain-to-Source Current (A) 1 01 01 01

0.1

0.1

TOP

воттом

VGS 15V 10V 6.0V 5.0V 4.8V 4.5V 4.3V 4.0V

1

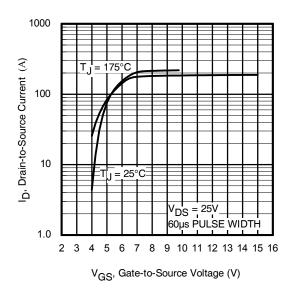


Fig. 3 Typical Transfer Characteristics

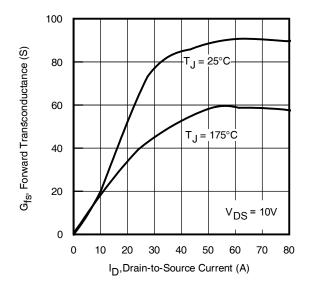
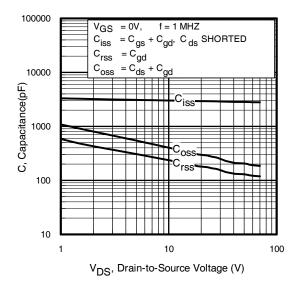
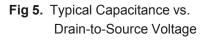


Fig. 4 Typical Forward Trans conductance Vs. Drain Current







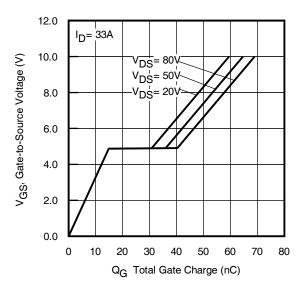


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

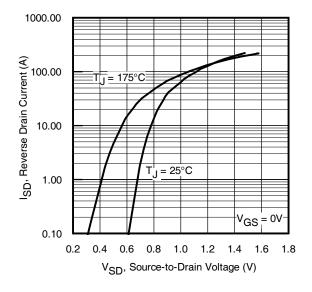


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

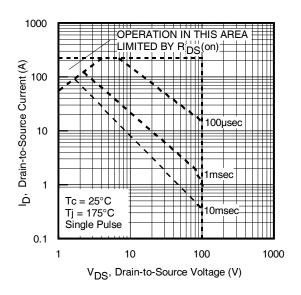
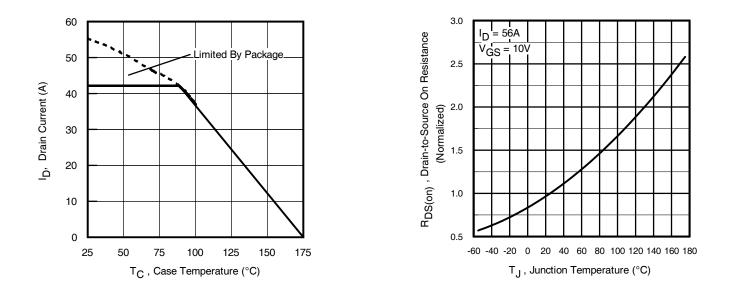
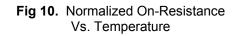


Fig 8. Maximum Safe Operating Area









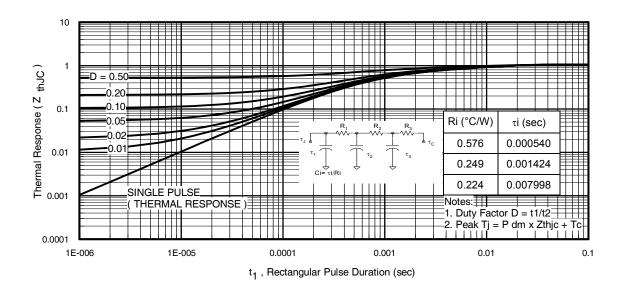


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

## AUIRFR3710Z

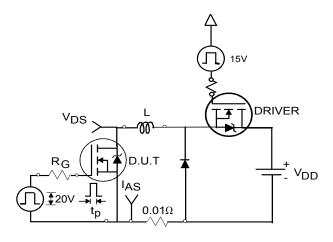
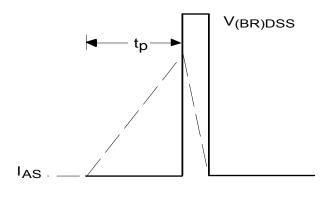
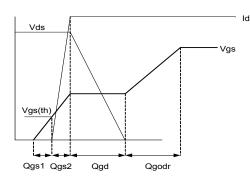


Fig 12a. Unclamped Inductive Test Circuit



#### Fig 12b. Unclamped Inductive Waveforms



#### Fig 13a. Gate Charge Waveform

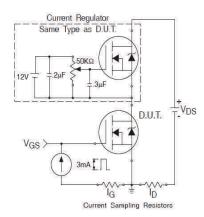
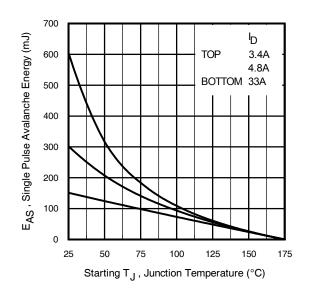
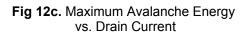


Fig 13b. Gate Charge Test Circuit





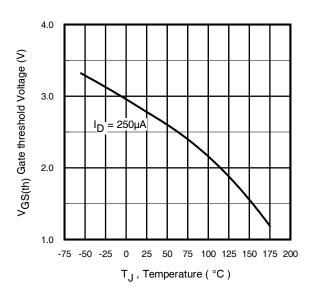


Fig 14. Threshold Voltage Vs. Temperature



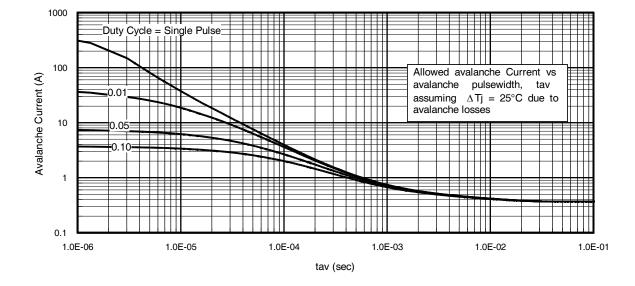
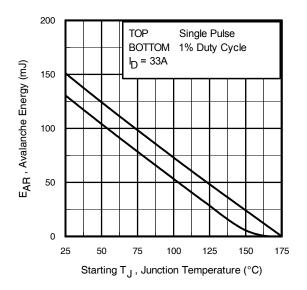
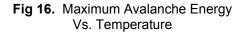


Fig 15. Typical Avalanche Current Vs. Pulse width





#### Notes on Repetitive Avalanche Curves , Figures 15, 16:

#### (For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T<sub>imax</sub>. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as Tjmax is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. Iav = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed T<sub>jmax</sub> (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche =  $t_{av} \cdot f$ 

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} \textbf{P}_{D (ave)} &= 1/2 \; ( \; 1.3 \cdot \textbf{BV} \cdot \textbf{I}_{av}) = \Delta T / \; \textbf{Z}_{thJC} \\ \textbf{I}_{av} &= 2 \Delta T / \; \textbf{[} 1.3 \cdot \textbf{BV} \cdot \textbf{Z}_{th} \textbf{]} \\ \textbf{E}_{AS (AR)} &= \textbf{P}_{D (ave)} \cdot \textbf{t}_{av} \end{split}$$



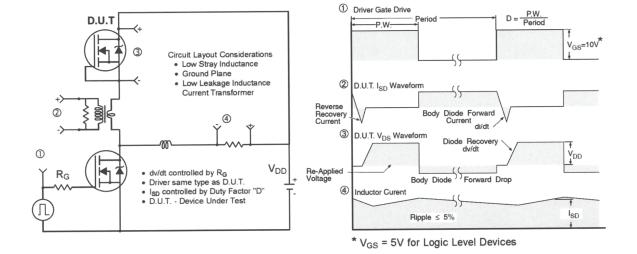


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

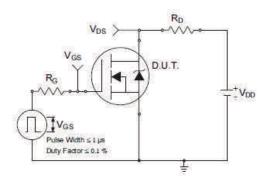


Fig 18a. Switching Time Test Circuit

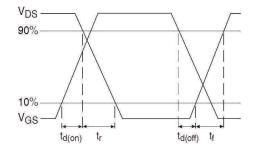
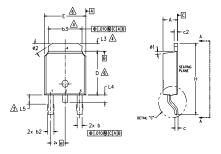


Fig 18b. Switching Time Waveforms

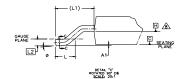


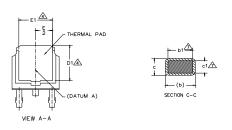
## AUIRFR3710Z

#### D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:
--------

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- A- LEAD DIMENSION UNCONTROLLED IN 15.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- A- DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.
- PLANE H. 2AA.

S Y		DIMEN	SIONS		N
M B	MILLIM	ETERS	INC	HES	0 T
0 L	MIN.	MAX.	MIN.	MAX.	ES
А	2.18	2.39	.086	.094	
A1	-	0.13	-	.005	
b	0.64	0.89	.025	.035	
b1	0.65	0.79	.025	.031	7
b2	0.76	1.14	.030	.045	
b3	4.95	5.46	.195	.215	4
с	0.46	0.61	.018	.024	
c1	0.41	0.56	.016	.022	7
c2	0.46	0.89	.018	.035	
D	5.97	6.22	.235	.245	6
D1	5.21	-	.205	-	4
Е	6.35	6.73	.250	.265	6
E1	4.32	-	.170	-	4
е	2.29	BSC	.090	BSC	
н	9.40	10.41	.370	.410	
L	1.40	1.78	.055	.070	
L1	2.74	BSC	.108	REF.	
L2	0.51	BSC	.020	BSC	
L3	0.89	1.27	.035	.050	4
L4	-	1.02	-	.040	
L5	1.14	1.52	.045	.060	3
ø	0.	10 <b>°</b>	0.	10 <b>°</b>	
ø1	0.	15 <b>°</b>	0.	15°	
ø2	25'	35*	25*	35*	

#### LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

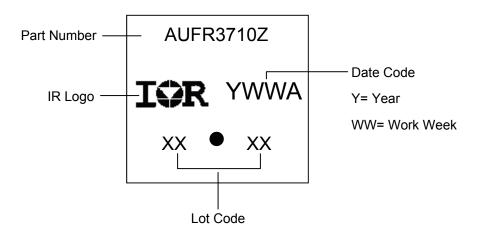
IGBT & CoPAK

1.- GATE

2.- COLLECTOR 3.- EMITTER

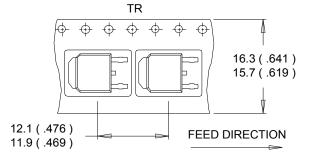
4.- COLLECTOR

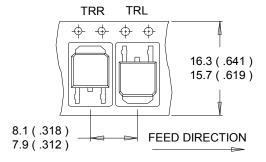
#### D-Pak (TO-252AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

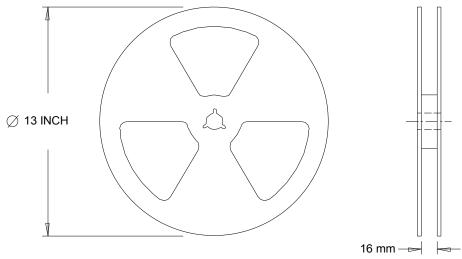
#### D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))





#### NOTES :

- 1. CONTROLLING DIMENSION : MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS ( INCHES ).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



#### NOTES :

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



#### **Qualification Information**

			Automotive (per AEC-Q101)			
Qualificat	ion Level	Comments: This part number(s) passed Automotive qualification. Infineon' Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moisture	Moisture Sensitivity Level		D-Pak MSL1			
			Class M4 <sup>†</sup>			
	Machine Model	AEC-Q101-002				
	Liveran Dady Madal		Class H1C <sup>†</sup>			
ESD	Human Body Model		AEC-Q101-001			
			Class C3 <sup>†</sup>			
Charged Device Model		AEC-Q101-005				
RoHS Cor	npliant	Yes				

#### + Highest passing voltage.

#### **Revision History**

Date	Comments		
11/23/2015	Updated datasheet with corporate template		
11/25/2015	Corrected ordering table on page 1.		

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